Scintillation Tile Hodoscope for the PANDA Barrel Time-Of-Flight Detector

William Nalti, Ken Suzuki, Stefan-Meyer-Institut, ÖAW on behalf of the PANDA/Barrel-TOF(SciTil) group

12.06.2018, ICASiPM2018

Outline

- Introduction: PANDA & FAIR
- Barrel TOF Design
- Single Tile Performance
- Larger Scale Integration

Tomorrow 11.45: Application of SiPMs and MCP-PMTs in the PANDA PID detectors - Albert Lehmann (Erlangen University)

PANDA Experiment at FAIR



Installation planned end-2021, with physics starting 2025

Barrel Time-of-Flight (TOF) Design



Capabilities and Requirements



- Collision time determination
- event sorting
 - 20 MHz interaction rate
- particle identification (PID)



Requirement: σt<100 ps to keep the efficiency loss due to event mixing in a tolerable level

Single Tile Design







	Sensitive area	Bias Voltage	Signal shape	Gain	V_{BD} adjustment
Single	1	V_{br} +OV	-	1	-
Series	N	$N \times (V_{br} + OV)$	faster	1/C	Yes
Parallel	N	V_{br} +OV	slower	С	No
Hybrid	N	V_{br} +OV	faster	1/C	No

Table 4.1: Comparison of series, parallel and hybrid connections of N SiPMs with reference of a single sensor.

Dual Module



Performance - single tile

Wrapping material Number of detected photons Time resolution [ps] Optimization of time-resolution No wrapping 55.0 ± 0.3 288 ± 2 Aluminised Mylar foil 52.7 ± 0.3 355 ± 2 Tyvek hardstructure 1057D 55.0 ± 0.3 394 ± 3 Enhanced specular reflector (ESR) 55.2 ± 0.3 355 ± 3 in terms of material, wrapping, Teflon tape 59.4 ± 0.3 408 ± 4 aluminium foil 54.2 ± 0.3 344 ± 3 Wrapping material Time resolution [ps] Number of detected photons threshold, overvoltage No wrapping 61.3 ± 0.3 371 ± 2 Aluminised Mylar foil 59.7 ± 0.3 445 ± 3 Discriminator TDC Amplifier

Very fine position dependence measurement of the performance with the optimised condition with well collimated ⁹⁰Sr source

In collaboration with Erlangen



Performance - single tile



HV 240V, threshold -30 mV, 2000 events/position, 3069 positions Mean time resolution σ = 53.9 ps

Performance – single Tile

thickness	Npe1	Npe2	time-resolution (ps)
3mm	72.37	46.84	60.34
4mm	85.64	55.14	68.09
5mm	139.94	128.69	50.14
5mm polished	111.87	78.1	48.29
6mm	101.7	70.7	48.7

Side view of the Sensorboard

Surface coverage = 1/4

scintillator (28.5x5 mm²)

SiPM (3x3 mm²)

LED

Temperature sensor

Run 47 / 5 mm polished





Barrel Timing Hodoscope, New Design



Micro Stripline Technique

- Coaxial-like structure to transmit signals over a PCB board, realised on a • multilayer PCB board, that feature:
 - High density •
 - Good shielding from external noise •
 - High bandwidth •
 - Low crosstalk •
 - Mechanical strength ٠



Crosstalk between the Micro Striplines (Prototype n°1)



Crosstalks can be reduced e.g. by using "via" and/or by optimizing the channel sequence

Probable Best Design

single ground layer interconnected at the board ends



lines shuffled to minimize the distance they share as direct neighbour

design not tested yet, due to considerable manufacture delay. Delivered last week.

This design = crosstalk reduction? Less copper as prototype 1 = material budget reduction.

due to some spare space on the railboard and no extra cost, few other designs were added and will be tested for comparison

Front End Electronics

66cm allocated for FEE

TOFPET2 ASIC readout

- Signal amplification and discrimination for each of 64 independent channels.
- Dual branch quad-buffered analogue interpolation TDCs for each channel.
- Quad-buffered charge integration for each channel.
- Dynamic range: 1500 pC.
- TDC time binning: 30 ps
- Gain adjustment per channel: 1, 1/2, 1/4, 1/8.
- SiPM family supported: positive or negative signal polarity
- Max channel hit rate: 480 kHz.
- Configurable timing, trigger and ToT thresholds.
- Fully digital output.
- Max output data rate: 2.6 Gb/s.









Test assembly with SiPM and ASIC board



SiPM + LYSO crystal

Summary

- Barrel Time-of-Flight Detector for PANDA
 - 240cm long, 5m² sensitive area, 15.360 SiPM, 2.000 Tiles, 4.000 channels
 - series connection of 4 SiPMs
 - Cable-less design with transmission lines over PCB board
 - $\sigma_t \sim 50$ ps, lab test. Beam test, see talk Albert Lehman (tomorrow 11:45)
 - Detector installation ~ 2022

Backup

Performance - single tile

Time resolution depend of Pole Zero Cancelation

Reproduced in 2017: 63.2ps for 1200 Ω and 53.4ps for 500 Ω

Bias voltage also has slight impact on time resolution

Threshold scan:

11.3mV	: 49,7 +/- 1,9 ps	
20mV	: 47.0 +/- 2.8 ps	
40mV	: 48.3 +/- 3.4 ps	
50mV	: 50.3 +/- 5.0 ps	
75mV	: 50.3 +/- 3.4 ps	

Best time-resolution for 20mV threshold



Capabilities and Requirements, and Detector Layout



- between the Barrel DIRC and the EMC
- high efficiency to charged particles
- blind to γs



Super Module - a half length prototype





Large PCB (railboard) production issue & Delivery Delay (3.5 months late)



Half-length was not a problem. Full length is. Production at CERN?

Monitoring and Calibration

- Voltage and current monitoring
 - the primary parameter that influences the characteristics of SiPM
 - general health check
- Temperature
 - SMD PTC on the sensor-board
 - relative: 200 mK, absolute: 4 K
- Gain
 - DCR: 10-100 kHz/mm²
- LED calibration system
 - SMD LED on the sensor-board

Model	V_{BD}	gain
KETEK	$18\mathrm{mV/K}$	$< 0.5\%/{ m K}$
Hamamatsu S13360	$50\mathrm{mV/K}$	$\sim 1.3\%/{ m K}$
AdvanSiD NUV	26 mV/K	$< 1\%/{ m K}$

Table 4.5: A short summary of temperature dependencies of SiPM characteristics. Values are taken from Ref. [10, 11, 12, 13]. The temperature dependence of break-down voltage of KETEK device is evaluated at 5 V over-voltage. Note that the absolute temperature coefficient of the gain is smaller at higher over-voltage. According to Ref. [10], the coefficient will be -0.7% at 2 V over-voltage.



SciRod (Erlangen) cont'd

More Time Resolutions (2)

Scintillator 5 x 5 x 50 mm³

Scintillator	MPPC	left		center		right
		σ_{t}	σ_{t}	σ_{t}	σ_{t}	σ_{t}
BC408	S10362-100P	68		103		74
	S12572-050P	74		67		68
BC420	S12572-050P	78		64		51

Scintillator 5 x 10 x 50 mm³

Scintillator	MPPC	left		center		right
		σ_{t}	σ_{t}	σ_{t}	σ_{t}	σ_{t}
BC408	S10362-100P	113		123		92

Scintillator 5 x 5 x 170 mm³

Scintillator	MPPC	left		center		right
		σ_{t}	σ_{t}	σ_{t}	σ_{t}	σ_{t}
BC408	S10362-100P	88	85	129	85	99

Longer and wider rods tend to give worse time resolution

The best time precision when triggering on the first photon? Analog SiPM

Time resolution of a scintillator tile read-out with the Hamamatsu SiPMs



No, the trigger threshold should not be set to the first detected photon, due to electronics noise and the SPTR of the SiPM.

The best time precision when triggering on the first photon? Analog SiPM

r analog SiPMs, this behaviour is changed due to electronics noise and the SPTF



Time resolution of a scintillator tile read-out with the Hamamatsu SiPMs

No, the trigger threshold should not be set to the first detected photon

SPTR of SiPMs

2 options: Hamamatsu or Ketek (3x3 mm2) AdvanSiD: worse timing, low PDE

SensL: also lower PDE

Ketek with optical trenches showed best results

Time resolution follows $1/\sqrt{N}$

We expect ~ 60 photons per SiPM: Hamamatsu 100P $\rightarrow \sigma \sim 40 \text{ ps}$ KETEK PM3350 $\rightarrow \sigma \sim 25 \text{ ps}$

[sd] 500 HLdS 400 = - 0°C ÷-10℃ 300 -200Hamamatsu 100 S10931-100P L L L L L L L L L L L L 0 0.2 0.4 0.6 0.8 1 1.2 1.4 1.6 1.8 Overvoltage [V] [sd] 500 BLLLS 400 – 20°C 10°C Ketek ⊖•0°C ÷-10℃ PM3350-B63 300 200100 °5

SPTR

500 -

10℃

"Time resolution below 100 ps for the SciTil detector of PANDA employing SiPM" with picosecond pulsed laser (400 nm)

S.E. Brunner, L. Gruber, J. Marton, H. Orth, K. Suzuki

Micro Stripline Technique

- Coaxial-like structure to transmit signals over a PCR board realised on a multilayer PCB board, that features
 - High density
 - Good shielding from external noise
 - High bandwidth
 - Low crosstalk
 - Mechanical strength



Complementary Designs Railboard v2.



Rate Capability



Signal Attenuation on the Micro Striplines



lation can be reduced by increasing the cross section of the signal

Crosstalks between Micro Striplines



geometry	number of	tile size	active area	fill factor
	tiles	mm^2	m^2	
reference	1	-	5.7	100 %
perfect super-modules	16	180×1800	5.2	91 %
design A	5760	28.5 imes 28.5	4.7	82 %
design B	1920	86.95×29.4	4.9	86 %

Efficiency

 Table 5.1: Properties of the studied Barrel TOF design options.



Sensor recovery time: ~50 ns, TOF-PET chip >300 kHz average through-put, Max tile hit-rate is ~40 kHz, TOF-PET chip has a buffer (4 hits) to cope with locally high-rate events

TOF-based Particle Identification



from simulation



Relative TOF

ÖAW AUSTRIAN ACADEMY OF SCIENCES

SMI - STEFAN MEYER INSTITUTE

Basic principle

- Calculate t_s for all possible particle species and all N tracks
 - Using reconstructed track parameters
 - p, K, π, μ, e
- evaluate all 5^N mass configurations
 - Compare their X² weights
 - Select the "most probable"



Panda Collaboration Meeting, Dominik Steinschaden, Mainz, 13.9.2016

Relative TOF



SMI – STEFAN MEYER INSTITUTE

t0 determination in Pandaroot

- Relative Tof algorithm implemented in local macros
 - Pid stage
- DPM generator
- Events with N>3 primary tracks matched with SciTil
- Mismatched tracks are rejected (MC information)



Radiation Hardness of SiPMs



Panda Collaboration Meeting, Sebastian Zimmermann, GSI, 07.12.2016

Radiation Hardness of SiPMs



Simulation of dark current increase

- Study done by V.A. Kaplin et al., "Time and Amplitude characteristics of large scintillation detectors with SiPM" -2015
- Dark current increase simulated by continuous low intensity illumination by an LED



Panda Collaboration Meeting, Sebastian Zimmermann, GSI, 07.12.2016

Radiation Hardness of SiPMs



Time resolution expectation

- Expected current between 8 and 40 µA/cm²
- For 3x3 mm² sensors: up to 360 μA
- Taking the measurements of KETEK and SensL sensors as a reference we expect deterioration of the time resolution by ~30% to ~70% over 10 years
- Reduced pixel dead time should reduce the effect of the radiation
 - Hamamatsu: 50 ns, KETEK & SensL: >200 ns
- True impact however is not known

Radiation Hardness of Scintillator Material



Panda Collaboration Meeting, Sebastian Zimmermann, GSI, 07.12.2016

Front End Electronics, DCS

TOFPET ASIC by	PETsys Electronics		
number of channels	64		
TDC time binning	50 ps (25 ps optional)		
intrinsic time resolu- tion	21 ps r.m.s.		
charge measurement	time over threshold (ToT)		
dynamic range	300 pC		
$\mathrm{SNR}~(\mathrm{Qin}=200~\mathrm{pF})$	25 dB		
coarse gain	G0, G0/2, G0/4		
SiPM familiy support	positive or negative sig- nal polarity		
on-chip calibration circuit	internal pulse genera- tor, programmable 6- bit amplitude		
max channel hit rate	160 kHz		
max output data rate	320 Mb/s (640 Mb/s with double data rate)		
Fully digital output	2 data LVDS links, DDR compatible		
operation frequency	80-160 MHz		
power per channel	8-11 mW		
SiPM HV fine biasing	range 500 mV		

Table 4.2: Summary of the specification of the TOF-PET ASIC by PETsys.





Monitoring and Calibration

- Voltage and current monitoring
 - the primary parameter that influences the characteristics of SiPM
 - general health check
- Temperature
 - SMD PTC on the sensor-board
 - relative: 200 mK, absolute: 4 K
- Gain
 - DCR: 10-100 kHz/mm²
- LED calibration system?
 - SMD LED on the sensor-board

Model	V_{BD}	gain
KETEK	$18\mathrm{mV/K}$	$< 0.5\%/{ m K}$
Hamamatsu S13360	$50\mathrm{mV/K}$	$\sim 1.3\%/{ m K}$
AdvanSiD NUV	26 mV/K	$< 1 \%/{ m K}$

Table 4.5: A short summary of temperature dependencies of SiPM characteristics. Values are taken from Ref. [10, 11, 12, 13]. The temperature dependence of break-down voltage of KETEK device is evaluated at 5 V over-voltage. Note that the absolute temperature coefficient of the gain is smaller at higher over-voltage. According to Ref. [10], the coefficient will be -0.7% at 2 V over-voltage.